

SSP7N60B/SSS7N60B

600V N-Channel MOSFET

General Description

These N-Channel enhancement mode power field effect transistors are produced using Fairchild's proprietary, planar, DMOS technology.

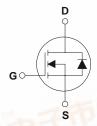
This advanced technology has been especially tailored to minimize on-state resistance, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation mode. These devices are well suited for high efficiency switch mode power supplies.

Features

- 7.0A, 600V, $R_{DS(on)} = 1.2\Omega @V_{GS} = 10 V$
- Low gate charge (typical 38 nC)
- Low Crss (typical 23 pF)
- Fast switching
- 100% avalanche tested
- Improved dv/dt capability
- TO-220F package isolation = 4.0kV (Note 6)







Absolute Maximum Ratings T_C = 25°C unless otherwise noted

Symbol	Parameter		SSP7N60B	SSS7N60B	Units
V _{DSS}	Drain-Source Voltage		6	00	V
I _D	Drain Current - Continuous (T _C = 25°C)		7.0	7.0 *	Α
	- Continuous (T _C = 100°C)		4.4	4.4 *	Α
I _{DM}	Drain Current - Pulsed	(Note 1)	28	28 *	Α
V _{GSS}	Gate-Source Voltage		± 30		V
E _{AS}	Single Pulsed Avalanche Energy	(Note 2)	420		mJ
I _{AR}	Avalanche Current	(Note 1)	7	7.0	
E _{AR}	Repetitive Avalanche Energy	(Note 1)	14.7		mJ
dv/dt	Peak Diode Recovery dv/dt	(Note 3)	5	.5	V/ns
P _D	Power Dissipation (T _C = 25°C)		147	48	W
	- Derate above 25°C		1.18	0.38	W/°C
T _J , T _{STG}	Operating and Storage Temperature Range		-55 to +150		°C
TL	Maximum lead temperature for soldering purposes, 1/8" from case for 5 seconds		30	00	°C

^{*} Drain current limited by maximum junction temperature

Thermal Characteristics

Symbol	Parameter	SSP7N60B	SSS7N60B	Units
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case Max.	0.85	2.6	°C/W
$R_{\theta CS}$	Thermal Resistance, Case-to-Sink Typ.	0.5		°C/W
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient Max.	62.5	62.5	°C/W

Symbol	Parameter	Test Conditions	Min	Тур	Max	Units
Off Cha	aracteristics					
BV _{DSS}	Drain-Source Breakdown Voltage	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$	600			V
ΔBV _{DSS} / ΔT _J	Breakdown Voltage Temperature Coefficient	$I_D = 250 \mu A$, Referenced to 25°C		0.65		V/°C
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} = 600 V, V _{GS} = 0 V			10	μА
		V _{DS} = 480 V, T _C = 125°C			100	μΑ
I _{GSSF}	Gate-Body Leakage Current, Forward	V _{GS} = 30 V, V _{DS} = 0 V		-	100	nA
I _{GSSR}	Gate-Body Leakage Current, Reverse	$V_{GS} = -30 \text{ V}, V_{DS} = 0 \text{ V}$		-	-100	nA
On Cha	aracteristics					
V _{GS(th)}	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_{D} = 250 \mu\text{A}$	2.0		4.0	V
R _{DS(on)}	Static Drain-Source On-Resistance	V _{GS} = 10 V, I _D = 3.5 A		1.0	1.2	Ω
9 _{FS}	Forward Transconductance	V _{DS} = 40 V, I _D = 3.5 A (Note 4)		8.2		S
C _{iss}	Input Capacitance Output Capacitance	V _{DS} = 25 V, V _{GS} = 0 V, f = 1.0 MHz		1380 115	1800 150	pF pF
		f = 1.0 MHz				pF
C _{rss}	Reverse Transfer Capacitance			23	30	pF
Switchi	ing Characteristics					
t _{d(on)}	Turn-On Delay Time	V _{DD} = 300 V, I _D = 7.0 A,		30	70	ns
t _r	Turn-On Rise Time	$R_G = 25 \Omega$		80	170	ns
t _{d(off)}	Turn-Off Delay Time	- 1.6		125	260	ns
t _f	Turn-Off Fall Time	(Note 4, 5)		85	180	ns
Q _g	Total Gate Charge	V _{DS} = 480 V, I _D = 7.0 A,		38	50	nC
Q _{gs}	Gate-Source Charge	V _{GS} = 10 V		6.4		nC
Q _{gd}	Gate-Drain Charge	(Note 4, 5)		15		nC
Q _{gd}	<u> </u>	(Note 4, 5)		15		n(
Drain-S	Source Diode Characteristics ar	ia maximani mamigo				
Drain-S	Source Diode Characteristics and Maximum Continuous Drain-Source Dic				7.0	Α
		ode Forward Current			7.0 28	A
I _S	Maximum Continuous Drain-Source Dic	ode Forward Current				
Is	Maximum Continuous Drain-Source Dick Maximum Pulsed Drain-Source Diode F	ode Forward Current Forward Current			28	Α

- $\label{eq:Notes:$

Typical Characteristics

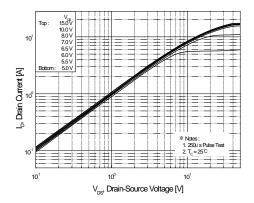


Figure 1. On-Region Characteristics

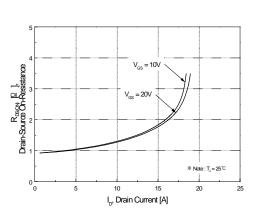


Figure 3. On-Resistance Variation vs Drain Current and Gate Voltage

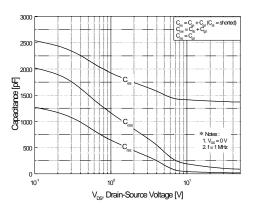


Figure 5. Capacitance Characteristics

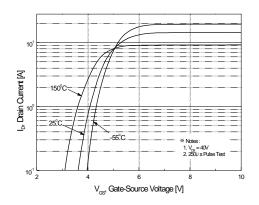


Figure 2. Transfer Characteristics

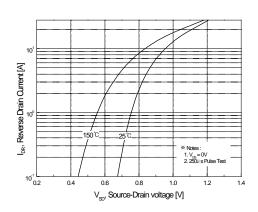


Figure 4. Body Diode Forward Voltage Variation with Source Current and Temperature

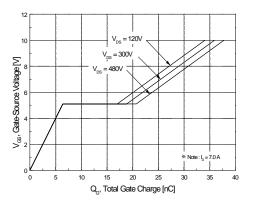


Figure 6. Gate Charge Characteristics

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Typical Characteristics (Continued)

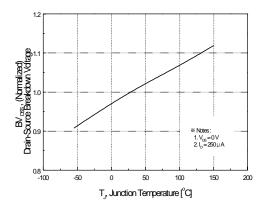


Figure 7. Breakdown Voltage Variation vs Temperature

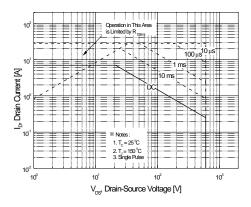


Figure 9-1. Maximum Safe Operating Area for SSP7N60B

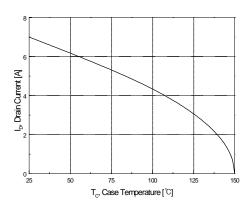


Figure 10. Maximum Drain Current vs Case Temperature

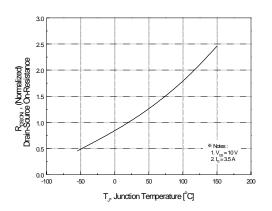


Figure 8. On-Resistance Variation

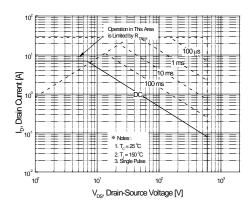


Figure 9-2. Maximum Safe Operating Area for SSS7N60B

Typical Characteristics (Continued)

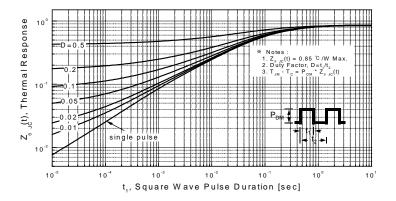


Figure 11-1. Transient Thermal Response Curve for SSP7N60B

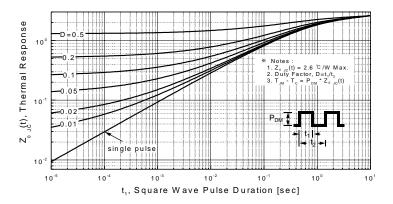
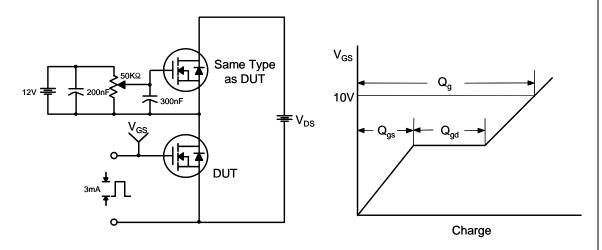


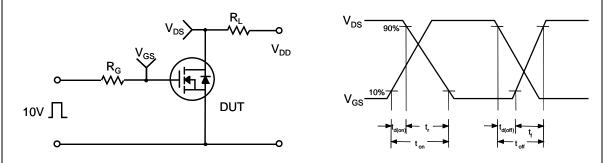
Figure 11-2. Transient Thermal Response Curve for SSS7N60B

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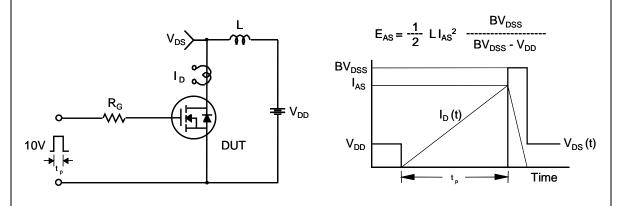
Gate Charge Test Circuit & Waveform



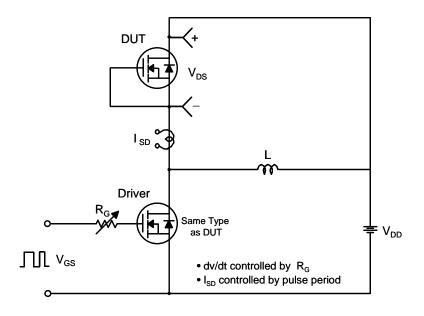
Resistive Switching Test Circuit & Waveforms

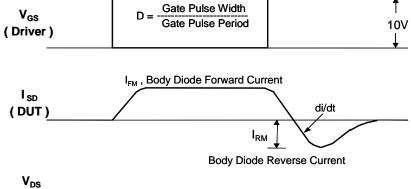


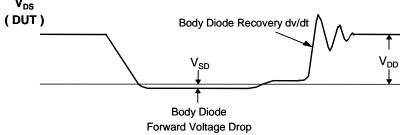
Unclamped Inductive Switching Test Circuit & Waveforms



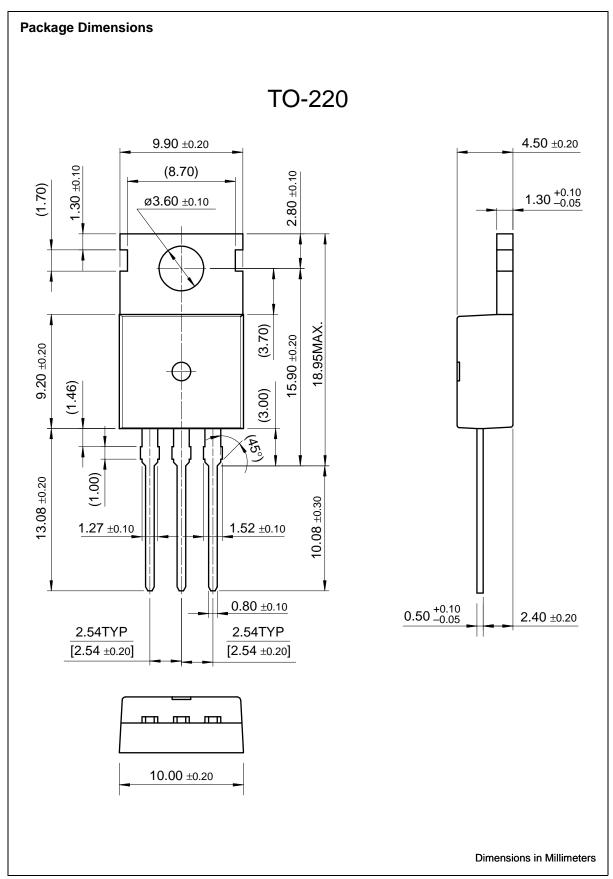
Peak Diode Recovery dv/dt Test Circuit & Waveforms

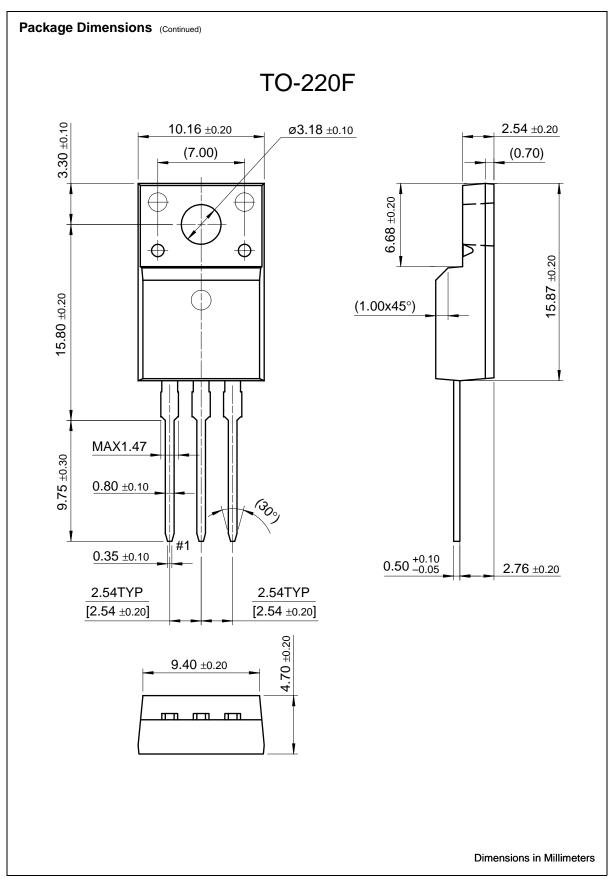






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